

Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-207001	Application No. 10/756,756
	Applicant Hajime Kimura et al.		
	Filing Date January 14, 2004	Group Art Unit 2673 2628	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
LB	AA	2002-0057244	05/16/2002	Koyama et al.	-	-	11/09/2001
LB	AB	2002-0135309	09/26/2002	Okuda	-	-	01/22/2002
LB	AC	2003-0048669	03/13/2003	Abe	-	-	08/29/2002
LB	AD	2003-0128199	07/10/2003	Kimura	-	-	10/29/2002
LB	AE	2003-0128200	07/10/2003	Yumoto	-	-	11/07/2001
LB	AF	2003-0156012	08/21/2003	Omidi et al.	-	-	12/21/2001
LB	AG	2003-0156102	08/21/2003	Kimura	-	-	10/29/2002
LB	AH	2003-0169250	09/11/2003	Kimura	-	-	10/29/2002
LB	AI	2004-0085029	05/06/2004	Kimura	-	-	10/30/2002
LB	AJ	2004-0085270	05/06/2004	Kimura	-	-	10/30/2002
LB	AK	2004-0207578	10/21/2004	Koyama	-	-	12/10/2003
LB	AL	2004-0222985	11/11/2004	Kimura	-	-	12/04/2003
LB	AM	2004-0257356	12/23/2004	Koyama	-	-	07/08/2004
LB	AN	2006-0028413	02/09/2006	Kimura	-	-	09/09/2005
LB	AO	5,138,310	08/11/1992	Hirane et al.	-	-	10/30/1990
LB	AP	5,266,936	11/30/1993	Saitoh	-	-	05/04/1992
LB	AQ	5,805,123	09/08/1998	Satoh et al.	-	-	03/18/1996
LB	AR	5,953,003	09/14/1999	Kwon et al.	-	-	10/06/1997
LB	AS	6,020,865	02/01/2000	Okuda et al.	-	-	10/02/1996
LB	AT	6,057,183	05/02/2000	Koyama et al.	-	-	11/19/1997
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LB	AV	6,229,506	05/08/2001	Dawson et al.	-	-	04/22/1998
LB	AW	6,268,842	07/31/2001	Yamazaki et al.	-	-	04/09/1999
LB	AX	6,331,844	12/18/2001	Okumura et al.	-	-	06/04/1997
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LB	BA	6,373,454	04/16/2002	Knapp et al.	-	-	06/09/1999

Examiner Signature <i>Jeff Piziali</i>	Date Considered <i>8-6-2007</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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JS	BC	6,501,466	12/31/2002	Yamagishi et al.	—	—	11/13/2000
JS	BD	6,545,652	04/08/2003	Tsuji	—	—	07/06/2000
JS	BE	6,586,888	07/01/2003	Kitahara et al.	—	—	03/22/2002
JS	BF	6,714,091	03/30/2004	Norskov et al.	—	—	12/19/2000
JS	BG	6,777,885	08/17/2004	Koyama	—	—	10/08/2002
JS	BH	6,809,320	10/26/2004	Iida et al.	—	—	09/17/2002
JS	BI	6,876,345	04/05/2005	Akimoto et al.	—	—	02/15/2002
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JS	BK	6,909,442	06/21/2005	Hiyama et al.	—	—	08/21/2002
JS	BL	6,914,390	07/05/2005	Koyama	—	—	11/19/2003
JS	BM	6,924,601	08/02/2005	Date	—	—	12/04/2003
JS	BN	6,927,753	08/09/2005	Koyama et al.	—	—	11/02/2001
JS	BO	6,952,194	10/04/2005	Yamazaki et al.	—	—	03/28/2000
JS	BP	6,952,228	10/04/2005	Yoneda et al.	—	—	10/10/2001
JS	BQ	6,954,035	10/11/2005	Chien et al.	—	—	01/14/2004
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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
JS	BT	EP1 063 630	27 DEC 2000	EUROPE	—	—	In English	
JS	BU	EP1 102 234	23 MAY 2001	EUROPE	—	—	In English	
JS	BV	JP06-118913	28 APR 1994	JAPAN	—	—	Full	
JS	BW	JP07-036410	07 FEB 1995	JAPAN	—	—	Abstract	
JS	BX	JP08-095522	12 APR 1996	JAPAN	—	—	Abstract	
JS	BY	JP08-101669	16 APR 1996	JAPAN	—	—	Abstract	

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							Yes	No
DB	BZ	JP08-106075	23 APR 1996	JAPAN	—	—	Abstract	
DB	CA	JP10-312173	24 NOV 1998	JAPAN	—	—	Full	
DB	CB	JP11-183870	09 JULY 1999	JAPAN	—	—	Abstract	
DB	CC	JP11-231834	27 AUG 1999	JAPAN	—	—	Abstract	
DB	CD	JP11-282419	15 OCT 1999	JAPAN	—	—	Abstract	
DB	CE	JP2000-122607	28 APR 2000	JAPAN	—	—	Abstract	
DB	CF	JP2000-194428	14 JULY 2000	JAPAN	—	—	Abstract	
DB	CG	JP2000-267164	29 SEP 2000	JAPAN	—	—	Abstract	
DB	CH	JP2001-005426	12 JAN 2001	JAPAN	—	—	Abstract	
DB	CI	JP2001-034221	09 FEB 2001	JAPAN	—	—	Abstract	
DB	CJ	JP2001-042822	16 FEB 2001	JAPAN	—	—	Abstract	
DB	CK	JP2001-042847	16 FEB 2001	JAPAN	—	—	Abstract	
DB	CL	JP2001-056667	27 FEB 2001	JAPAN	—	—	Full	
DB	CM	JP2001-147659	29 MAY 2001	JAPAN	—	—	Abstract	
DB	CN	JP2001-290469	19 OCT 2001	JAPAN	—	—	Abstract	
DB	CO	JP2002-215095	31 JULY 2002	JAPAN	—	—	Abstract	
DB	CP	JP2002-278497	27 SEP 2002	JAPAN	—	—	Abstract	
DB	CQ	JP2002-514320	14 MAY 2002	JAPAN	—	—	Abstract	
DB	CR	JP2002-517806	18 JUNE 2002	JAPAN	—	—	Abstract	
DB	CS	JP2003-066903	05 MAR 2003	JAPAN	—	—	Abstract	
DB	CT	JP3287391	04 JUN 2002	JAPAN	—	—	Abstract	
DB	CU	JP62-122488	04 AUG 1987	JAPAN	—	—	Full	
DB	CV	WO98-048403	29 OCT 1998	WIPO / PCT	—	—	In English	
DB	CW	WO99-065011	16 DEC 1999	WIPO / PCT	—	—	In English	
DB	CX	WO02-039420	16 MAY 2002	WIPO / PCT	—	—	Abstract	
DB	CY	WO03-034381	24 APR 2003	WIPO / PCT	—	—	In English	
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Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
JS	DA	Yumoto et al., "Pixel-Driving Methods for Large-Sized Poly-Si AM-OLED Displays," <i>Asia Display / IDW '01</i> , Jan. 1, 2001, pp. 1395-1398.
US	DB	Hattori et al., "Analog-Circuit Simulation of the Current-Programmed Active-Matrix Pixel Electrode Circuits Based on Poly-Si TFT for Organic Light-Emitting Displays," <i>Digest of Technical Papers, AM-LCD '01</i> , July 11, 2001, pp. 223-226.
US	DC	Abe et al., "A Poly-Si TFT 6-bit Current Data Driver for Active Matrix Organic Light Emitting Diode Displays," <i>EuroDisplay '02</i> , Jan. 1, 2002, pp. 279-282.
US	DD	R. Hattori, "Data-Line Driver Circuits for Current-Programmed Active-Matrix OLED Based on Poly-Si TFT's," <i>Digest of Technical Papers AM-LCD '02</i> , Jan. 1, 2002, pp. 17-20

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DB	AC	2002/0180369	12/05/2002	KOYAMA	—	—	02/20/2002
DB	AD	2004/0085270	05/06/2004	KIMURA	—	—	10/30/2002
DB	AE	2004/0207578	10/21/2004	KOYAMA	—	—	12/10/2003
DB	AF	2004/0232952	11/25/2004	KIMURA et al.	—	—	01/14/2004
DB	AG	2004/0239599	12/02/2004	KOYAMA	—	—	07/02/2004
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DB	AJ	3,982,172	09/21/1976	VAN DE PLASSCHE	—	—	04/16/1975
DB	AK	4,967,140	10/30/1990	GROENEVELD et al.	—	—	07/14/1989
DB	AL	6,747,624	06/08/2004	UDO et al.	—	—	02/09/2000
DB	AM	6,777,710	08/17/2004	KOYAMA	—	—	02/20/2002
DB	AN	6,801,061	10/05/2004	COWLES	—	—	08/29/2002
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						

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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
DB	AU	0359315	03/21/1990	Europe	—	—	In English	
DB	AV	1202242	05/02/2002	Europe	—	—	In English	
DB	AW	1486942	12/15/2004	Europe	—	—	In English	
DB	AX	1577869	09/21/2005	Europe	—	—	In English	

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							Yes	No
RD	AY	2001-056664	02/27/2001	Japan	—	—	Abstract	
DB	AZ	2002-221936	08/09/2002	Japan	—	—	Abstract	
OB	AAA	2002-251166	09/06/2002	Japan	—	—	Abstract	

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
DB	ABB	GROENEVELD D. et al., "A Self-Calibration Technique for Monolithic High-Resolution D/A Converters", IEEE Journal of Solid-State Circuits, 1989, Vol. 24, No. 6, pp. 1517-1522
OB	ACC	TAN S. et al., "32.4: Designing of Circuit Building Blocks for OLED-on-Silicon Microdisplays", SID DIGEST 02: SID International Symposium Digest of Technical Papers, 2002, pp. 980-983
OB	ADD	Supplementary European Search Report (Application No. EP 03780930.8, PCT/JP0316354 dated February 20, 2007), 5 pages.
	AEE	

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